Search Notes		

Application/Control	No. Applicant(s) Reexaminat	/Patent under ion
09/880,173	ASANO, TO	OMOYUKI
Examiner	Art Unit	
Frantzy Poinvil	3628	

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Class	Subclass	Date	Examiner
705	14-80	3/28/2006	FP
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INT	INTERFERENCE SEARCHED		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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